



Notice of References Cited

Application/Control No. 09/755,207	Applicant(s)/Patent Under Reexamination CHEN ET AL.		
Examiner	Art Unit		
Tu X Nguyen	2684	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A ¹	US_2002/0065080	05-2002	Pittampalli et al.	455/439
	В	US-2002/0097780	07-2002	Odenwalder et al.	375/146
-	C	US-6,160,999	12-2000	Chheda et al.	455/69
	D	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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